


<b>Search Notes</b> 	<b>Application/Control No.</b> 10728591	<b>Applicant(s)/Patent Under Reexamination</b> LEE ET AL.
	<b>Examiner</b> DABORAH CHACKO DAVIS	<b>Art Unit</b> 1795

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
(361/748,763;174/260;430/313,311)Updated text search only-see updated search history print out-	03/12/2009	dcd
EAST (US-PGPUB, USPAT, FPRS, EPO, JPO, DERWENT, IBM-TDB) See updated search history print out	03/12/2009	dcd
Updated search history print out	03/12/2009	dcd
Updated eDAN inventor search	03/12/2009	dcd

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference search performed-see updated search history print out	03/12/2009	dcd

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